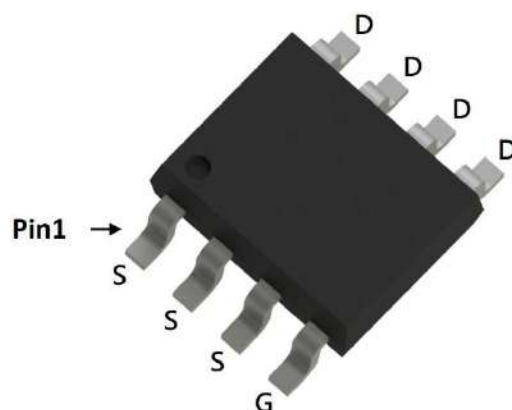


P-Channel Enhancement Mode Power MOSFET

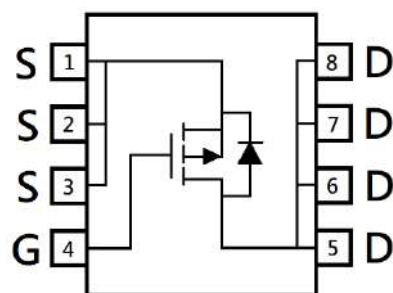
Features:

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Pb-free and Halogen-free package

SOP-8



BV_{DSS}	-30V
$I_D @ V_{GS} = -10V, T_C = 25^\circ C$	-25A
$I_D @ V_{GS} = -10V, T_A = 25^\circ C$	-11A
$R_{DS(ON)} \text{ typ.} @ V_{GS} = -10V, I_D = -10A$	$8m\Omega$
$R_{DS(ON)} \text{ typ.} @ V_{GS} = -4.5V, I_D = -8A$	$12m\Omega$



G : Gate S : Source D : Drain

Ordering Information

Device	Package	Shipping
KSC4409	SOP-8 (Pb-free lead plating and halogen-free package)	4000 pcs / tape & reel

Absolute Maximum Ratings ($T_C=25^{\circ}\text{C}$, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	-30	V
Gate-Source Voltage	V_{GS}	± 25	
Continuous Drain Current @ $V_{GS}=-10\text{V}$, $T_A=25^{\circ}\text{C}$	I_D	-15	A
Continuous Drain Current @ $V_{GS}=-10\text{V}$, $T_A=100^{\circ}\text{C}$		-9.5	
Pulsed Drain Current (Note 1)	I_{DM}	-160	
Avalanche Current @ $L=1\text{mH}$	I_{AS}	-15	
Avalanche Energy @ $L=1\text{mH}$, $I_D=-15\text{A}$, $V_{DD}=-15\text{V}$	E_{AS}	113 (Note3)	mJ
Power Dissipation (Note 2)	P_D	$T_A=25^{\circ}\text{C}$	W
		$T_A=100^{\circ}\text{C}$	
Operating Junction and Storage Temperature Range	$T_j ; T_{stg}$	-55~+150	$^{\circ}\text{C}$

Note : 1.Pulse width limited by maximum junction temperature.

2.Surface mounted on 1 in² copper pad of FR-4 board, $t \leq 10\text{s}$.

3.100% tested by conditions of $L=0.1\text{mH}$, $I_{AS}=-15\text{A}$, $V_{GS}=-10\text{V}$, $V_{DD}=-15\text{V}$

Electrical Characteristics ($T_C=25^{\circ}\text{C}$, unless otherwise noted)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV_{DSS}	-30	-	-	V	$V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$
$V_{GS(th)}$	-1	-	-2.5		$V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$
I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 25\text{V}$, $V_{DS}=0\text{V}$
I_{DSS}	-	-	-1	μA	$V_{DS}=-24\text{V}$, $V_{GS}=0\text{V}$
	-	-	-10		$V_{DS}=-20\text{V}$, $V_{GS}=0\text{V}$, $T_j=125^{\circ}\text{C}$
$R_{DS(ON)}$ (Note 1)	-	6.5	9	m $\wedge$	$I_D=-15\text{A}$, $V_{GS}=-10\text{V}$
	-	9.9	15		$I_D=-10\text{A}$, $V_{GS}=-4.5\text{V}$
G_{FS} (Note 1)	-	28	-	S	$V_{DS}=-10\text{V}$, $I_D=-15\text{A}$
Dynamic					
C_{iss}	-	2782	-	pF	$V_{DS}=-15\text{V}$, $V_{GS}=0\text{V}$, $f=1\text{MHz}$
C_{oss}	-	371	-		
C_{rss}	-	235	-		
$t_{d(ON)}$ (Note 1&2)	-	12.8	-	ns	$V_{DS}=-15\text{V}$, $I_D=-15\text{A}$, $V_{GS}=-10\text{V}$, $R_G=3\Omega$
t_r (Note 1&2)	-	19.8	-		
$t_{d(OFF)}$ (Note 1&2)	-	110.2	-		
t_f (Note 1&2)	-	49.6	-		
$Q_g(V_{GS}=10\text{V})$ (Note 1&2)	-	53.8	-	nC	$V_{DS}=-15\text{V}$, $I_D=-15\text{A}$, $V_{GS}=-10\text{V}$
$Q_g(V_{GS}=4.5\text{V})$ (Note 1&2)	-	27	-		
Q_{gs} (Note 1&2)	-	9	-		
Q_{gd} (Note 1&2)	-	11	-		
R_g	-	13.5	-	$\wedge$	$f=1\text{MHz}$

Electrical Characteristics(Cont.) (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Source-Drain Diode					
I _S	-	-	-10	A	
I _{SM} (Note 3)	-	-	-40		
V _{SD} (Note 1)	-	-0.8	-1.2	V	I _F =I _S , V _{GS} =0V
trr	-	16.6	-	ns	I _F =-10A, dI _F /dt=100A/μs
Q _{rr}	-	8.3	-	nC	

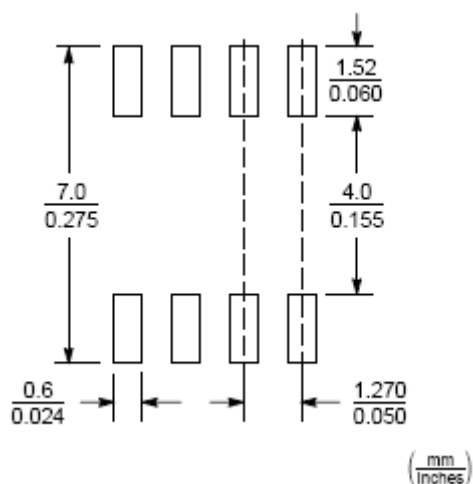
Note : 1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%
 2.Independent of operating temperature
 3.Pulse width limited by maximum junction temperature

Thermal Resistance Ratings

Thermal Resistance	Symbol	Typical	Maximum	Unit
Junction-to-Case	R _{θJC}	22	25	°C / W
Junction-to-Ambient (Note)	R _{θJA}	33	40	

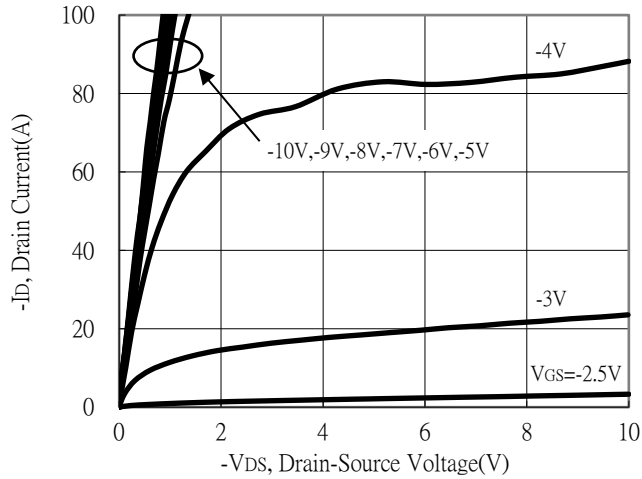
Note : W when mounted on a 1 in² pad of 2 oz copper, t≤10s; 125°C/W when mounted on minimum copper pad.

Recommended Soldering Footprint

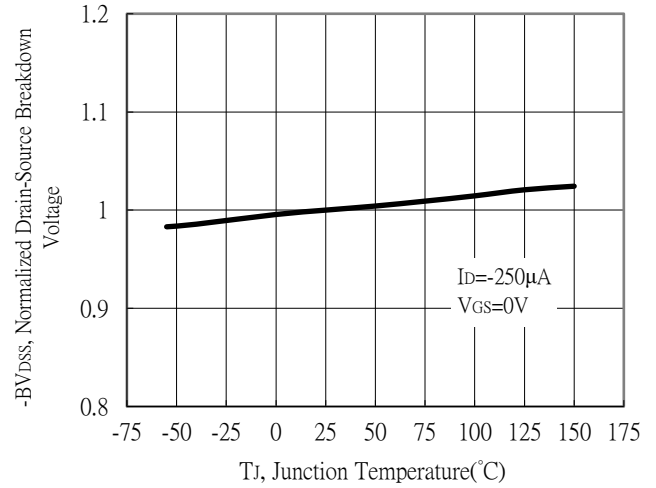


Typical Characteristics

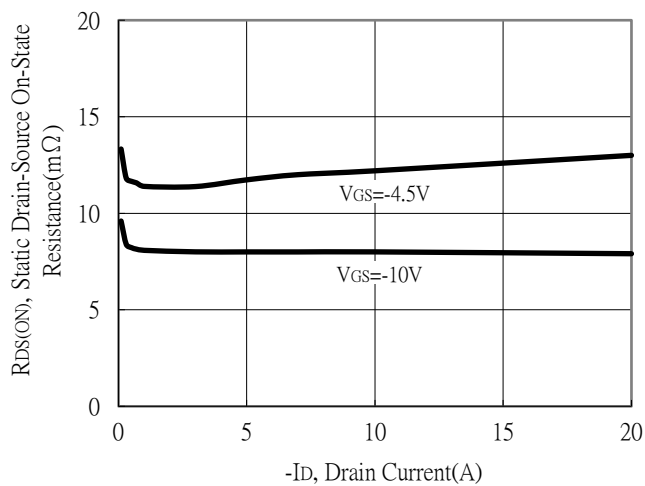
Typical Output Characteristics



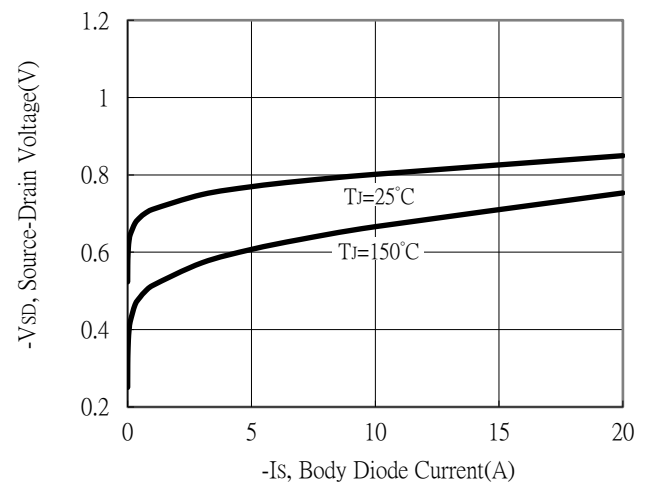
Breakdown Voltage vs Ambient Temperature



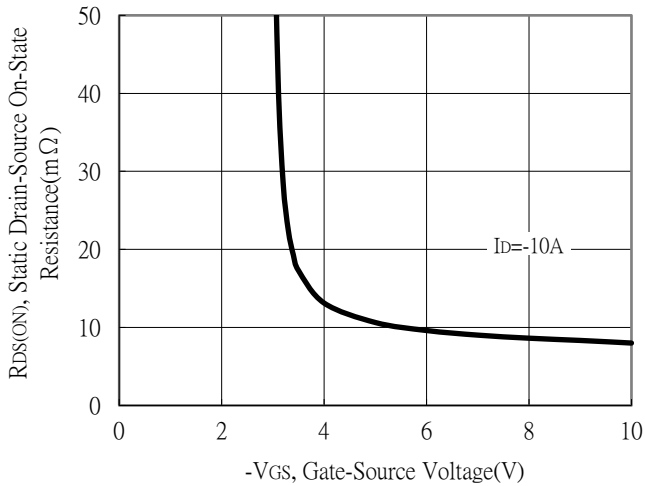
Static Drain-Source On-State resistance vs Drain Current



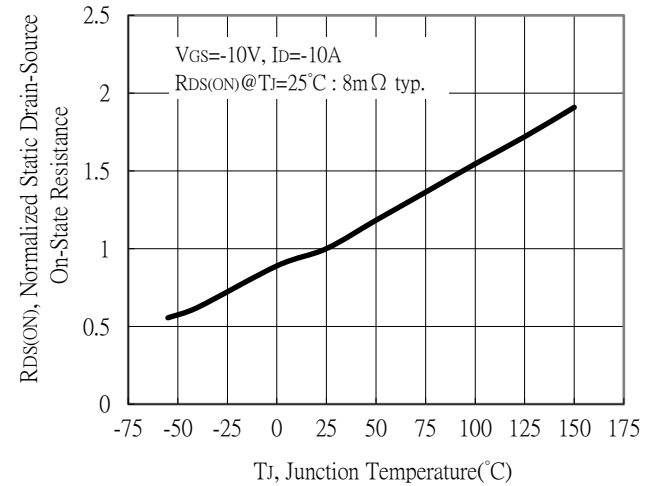
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

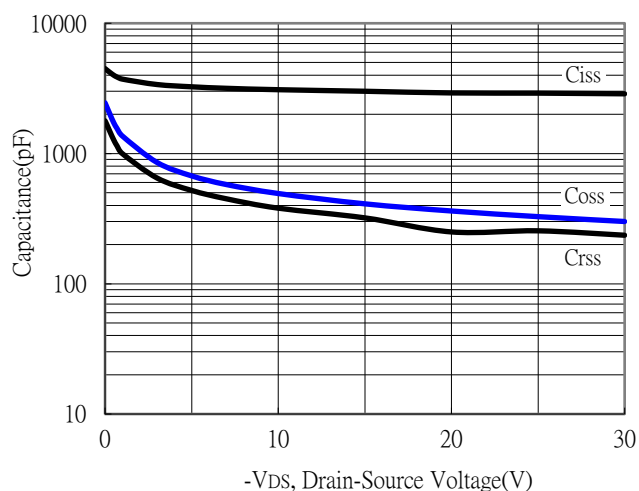


Drain-Source On-State Resistance vs Junction Temperature

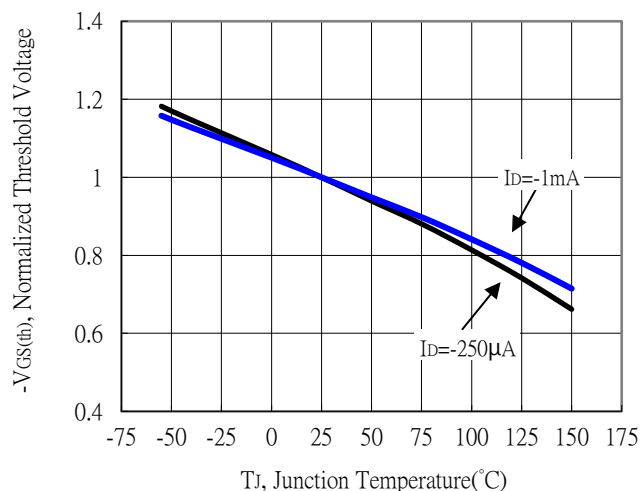


Typical Characteristics (Cont.)

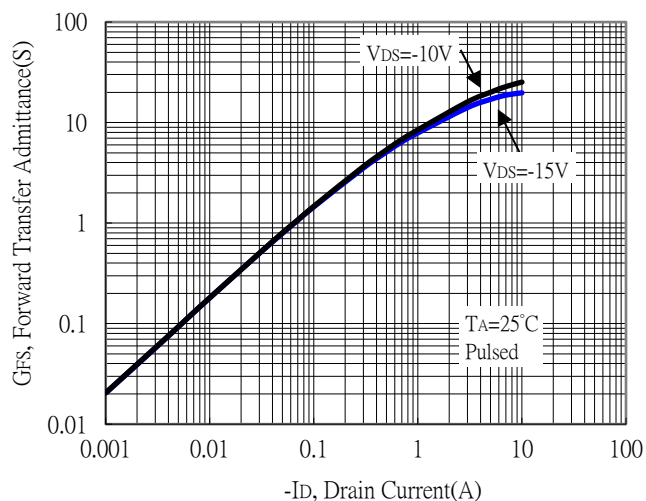
Capacitance vs Drain-to-Source Voltage



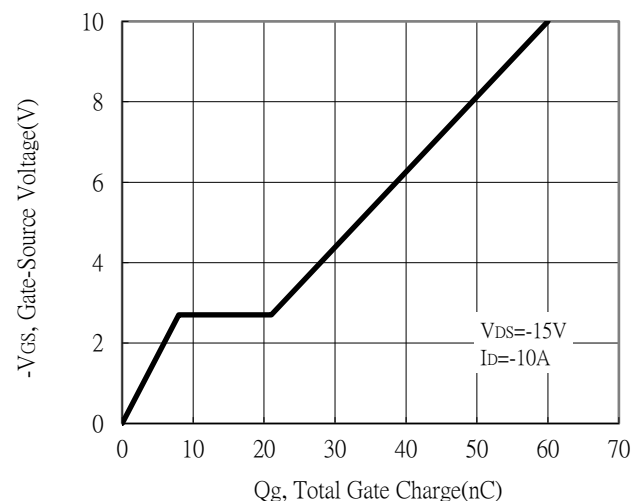
Threshold Voltage vs Junction Temperature



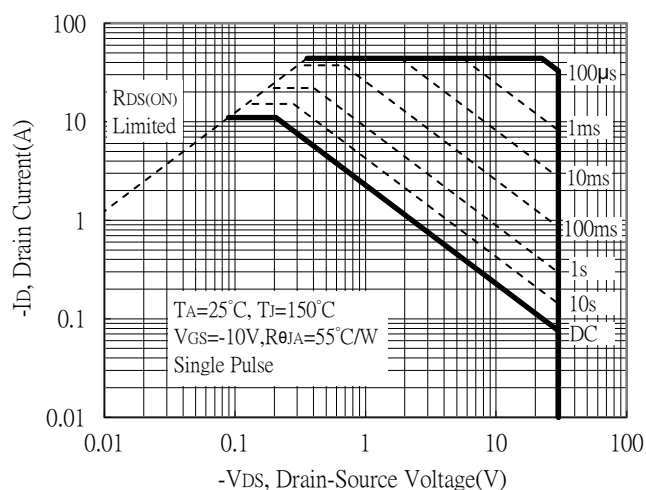
Forward Transfer Admittance vs Drain Current



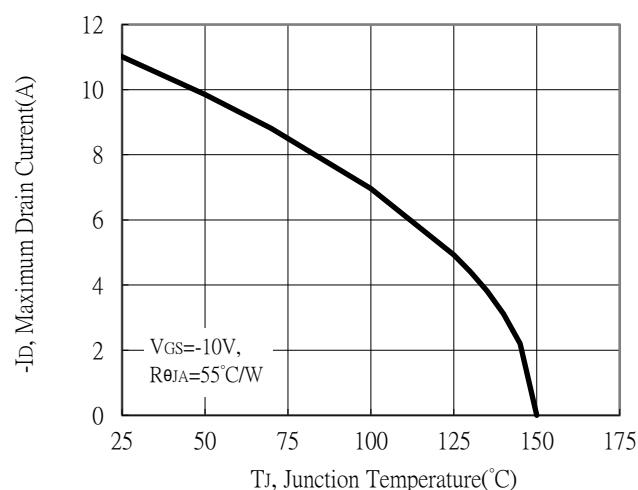
Gate Charge Characteristics



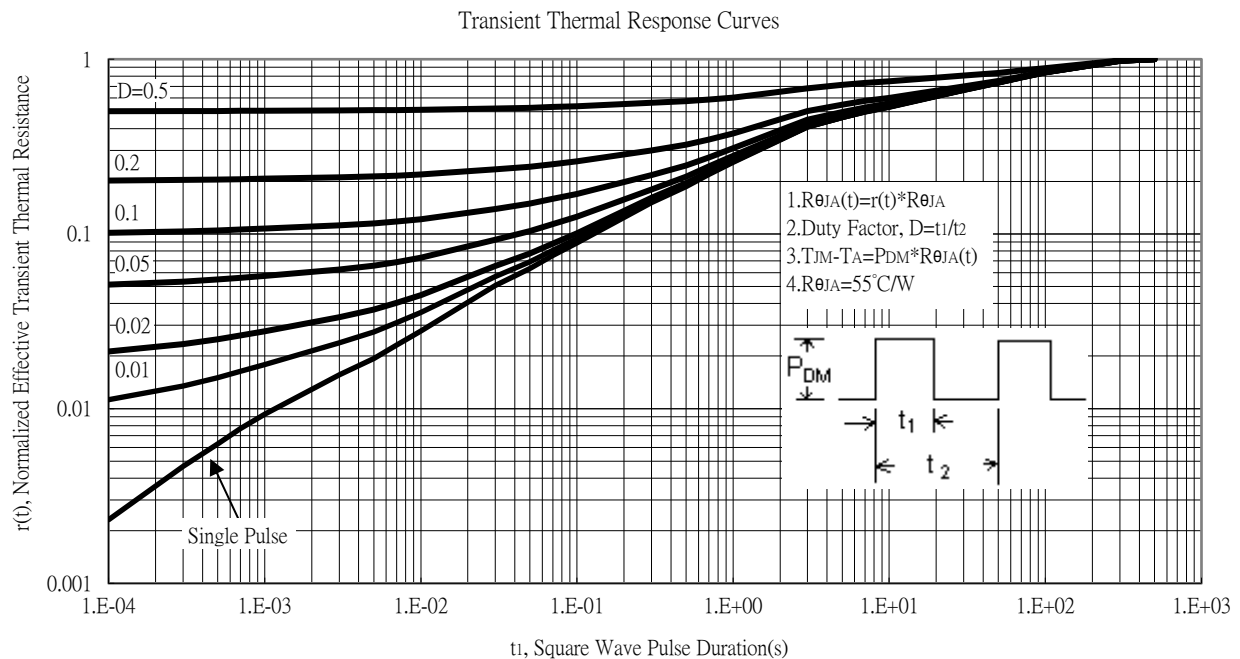
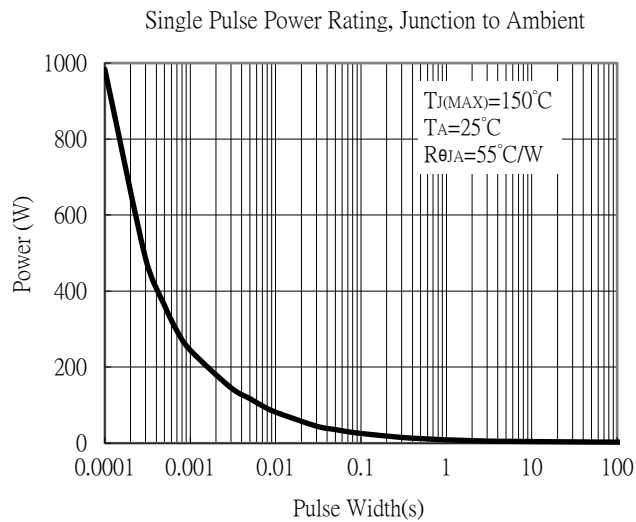
Maximum Safe Operating Area



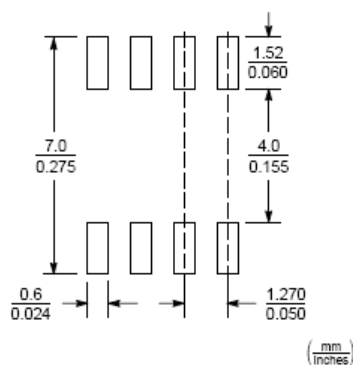
Maximum Drain Current vs Junction Temperature



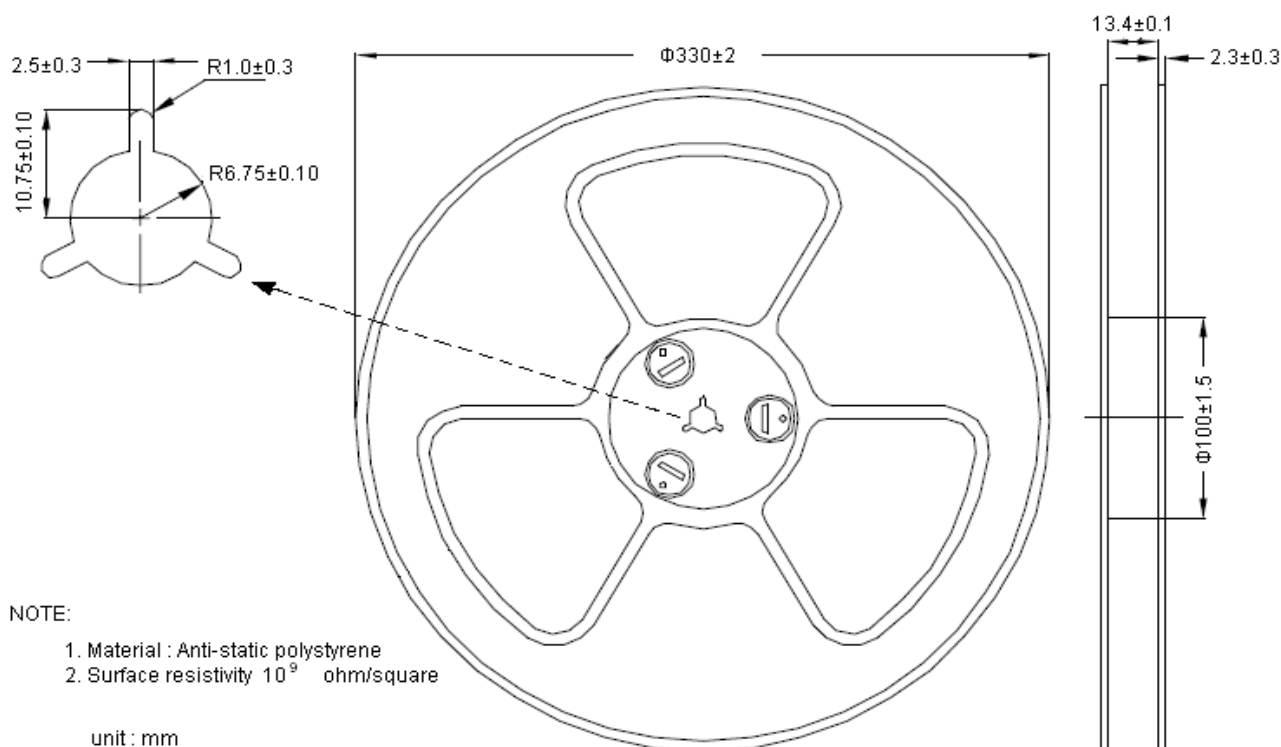
Typical Characteristics (Cont.)



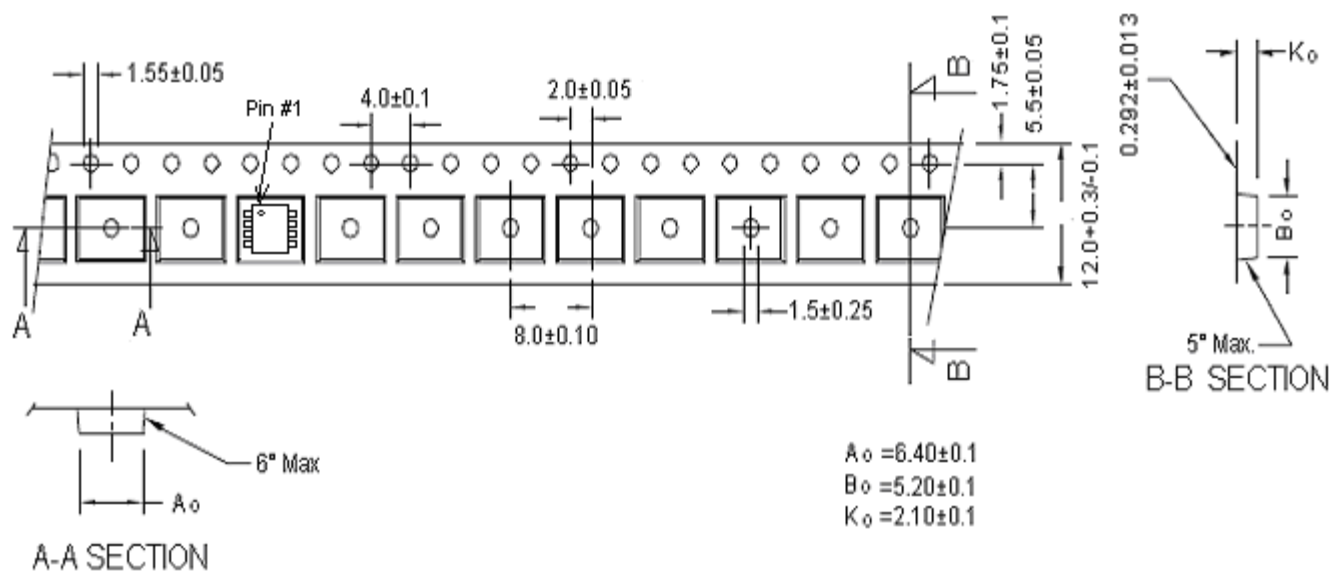
Recommended Soldering Footprint



Reel Dimension



Carrier Tape Dimension

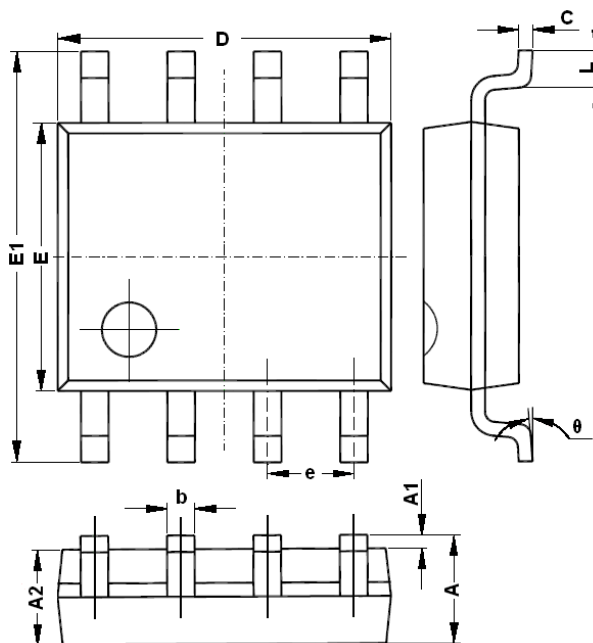


Notes:

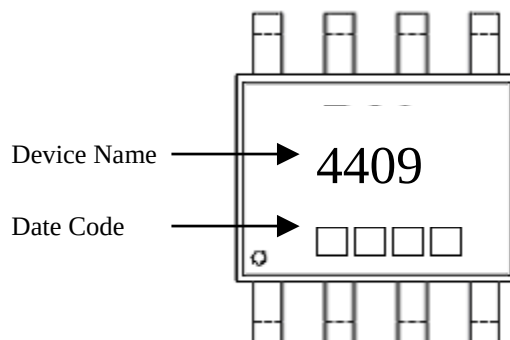
1. 10 sprocket hole pitch cumulative tolerance ± 0.2 .
2. Camber not to exceed 1mm in 100mm.
3. Material: conductive black polystyrene
4. A_0 & B_0 measured on a plane 0.3mm above the bottom of the pocket.
5. K_0 measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

Unit : millimeter

SOP-8 Dimension



Marking:



Date Code(counting from left to right) :

1st code: year code, the last digit of Christian year

2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D

May→E, Jun→F, Jul→G, Aug→H, Sep→J, Oct→

K, Nov→L, Dec→M

3rd and 4th codes : production serial number, 01~99

8-Lead SOP-8 Plastic Package

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	1.270 (BSC)		0.050 (BSC)	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0	8°	0	8°
D	4.700	5.100	0.185	0.200					